


<b>Search Notes</b>  	<b>Application/Control No.</b>  10766700	<b>Applicant(s)/Patent Under Reexamination</b>  PRATT ET AL.
	<b>Examiner</b>  Lee, John W	<b>Art Unit</b>  2624

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	305	10/12/2007	John W. Lee

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor Search	10/12/2007	John W. Lee
EAST Search	10/12/2007	John W. Lee
EAST Search	6/17/2009	John W. Lee

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/JOHN W LEE/ Examiner.Art Unit 2624	
--	--